IN THE U.S. PATENT AND TRADEMARK OFFICE

In re application of

Yasuhiko KASAMA et al.

Conf.

Application No. NEW NATIONAL PHASE

Group

Filed June 2, 2006

Examiner

SYSTEM FOR MANUFACTURING A FULLERENE DERIVATIVE AND METHOD FOR MANUFACTURING

INFORMATION DISCLOSURE STATEMENT (SUBMISSION CONCURRENT WITH THE FILING OF A NEW PATENT APPLICATION)

Assistant Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

June 2, 2006

Sir:

Pursuant to 37 C.F.R. §§ 1.97 and 1.98, and in fulfillment of the duty of disclosure under 37 C.F.R. § 1.56, applicant(s) hereby submit(s) an Information Disclosure Statement for consideration by the Examiner.

I. LIST OF PATENTS, PUBLICATIONS OR OTHER INFORMATION

The patents, publications, or other information submitted for consideration by the Office are listed on PTO-1449, attached hereto. $\,$

II. COPIES

			blications			
		waived 2003.	submission	n for	app	olications

- Submitted herewith is a legible copy of (i) each foreign patent; (ii) each publication or that portion which caused it to be listed; and (iii) all other information or that portion which caused it to be listed.
- This application is a National Phase of a PCT application. Some or all of the documents listed on the PTO-1449 are not enclosed because they were cited in the International Search Report and copies should have been forwarded from the International Search Authority pursuant to the trilateral agreement between the USPTO, EPO and JPO, or they are U.S. patents or U.S. published applications. If copies are needed, please contact the undersigned.

Docket No. 8075-1097

III.	CONCI	SE EX	RPLANATION OF THE RELEVANCE PROCESS OF 1000 OF
	a.		DOCUMENTS IN THE ENGLISH LANGUAGE
			The attached non U.S. patents, non U.S. patent application publications, foreign publications, or other information in the English language do not require a statement of relevancy.
	b.		DOCUMENTS NOT IN THE ENGLISH LANGUAGE
			A concise explanation of the relevance of all patents, publications, or other information listed that is not in the English language is as follows:
	c.		FOREIGN SEARCH REPORT OR ACTION
			An English language version of the search report or action that indicates the degree of relevance found by the foreign office is attached, thereby satisfying the requirement for a concise explanation. See MPEP 609(A)(3).
	d.		OTHER
			The following additional information is provided for the Examiner's consideration.
			FEES
concu	This errent efore,	Inf	formation Disclosure Statement is being filed with the filing of a new patent application; fee is required.
is re	If Thequest	ne Ex	aminer has any questions concerning this IDS, he/she contact the undersigned.
			Respectfully submitted,
			Benoit Castel, Reg. No. 35,041 745 South 23 rd Street Arlington, VA 22202 Telephone (703) 521-2297 Telefax (703) 685-0573 (703) 979-4709
BC/mg	os		
Enclo	sures	3 :	<pre> Form PTO-1449(s) Documents Foreign Search Report Other:</pre>

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INFO	PRMATION DISCLOSURE O	CITATION	Attorney Docket No.: 8075-1097			Application No.: NEW NATIONAL PHASE					
	IN AN APPLICATION	Applicant: Yasuhiko KASAMA et al.									
	(Use several sheets if necessary	Filing Date: June 2, 2006			Group Art Unit:						
		U.S. PATEN	T DOCUMENTS								
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not in cor	nformance and not considered. Includ	de copy of this fo	rm with next communication t	o the appl	ican	t.					

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^{*} English language abstract provided for the Examiner's convenience